

Notice of References Cited	Application/Control No. 10/630,993	Applicant(s)/Patent Under Reexamination MACKIEWICZ, JOHN EDMUND	
	Examiner Lan Nguyen	Art Unit 3683	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,319,668	03-1982	Johnson et al.	188/72.4
	B	US-5,588,508	12-1996	Le Deit, Gerard	188/73.31
	C	US-6,296,085	10-2001	Yukoku, Shinichiro	188/73.36
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 54129260 A	10-1979	Japan	TSURUTA et al.	F16D 55/224
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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